

Encoder device iC-MN is a 3-channel, simultaneous sampling sine-to-digital converter which interpolates sine/cosine sensor signals using a high precision SAR converter with a selectable resolution of up to 13 bits. Each input has a separate sample-and-hold stage which halts the track signal for the subsequent sequential digitization. Various 2- and 3-track Nonius scale computations (after Vernier) can be configured for the calculation of high resolution angle positions; these computations permit angle resolutions of up to 25 bits.

The absolute angle position is output via the serial BiSS Interface with clock rates of up to 10 Mbit/s. The RS422 transceiver required to this end is integrated on the chip.

Applications

- Optical and magnetic position sensors
- Singleturn and multiturn absolute encoders
- Linear scales for absolute position

Features

- 3-Ch. simultaneous sampling 13 bit sine-to-digital conversion
- 2- and 3-track Nonius scale computation (after Vernier)
- Reduced conversion times due to internal flash counter
- Synchronization of multiturn sensors via on-chip BiSS master
- Differential PGA inputs, single-ended signal capable
- Selectable input resistance permits voltage or current signals
- Signal conditioning for offset, amplitude and phase
- Short-circuit-proof RS422 drive to 10 Mbit/s for BiSS data line
- SSI data output formats selectable
- Short-circuit-proof sine/cosine output drivers (1 Vpp to 100Ω)
- Signal level controllers for direct supply of encoder LEDs and MR bridges
- Configurable system monitoring and alarm indication
- Position preset function
- Device setup from serial EEPROM and BiSS
- Full reverse polarity protection including the sub-system
- Immune against faulty output or supply connections



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iC-MN 25-BIT NONIUS ENCODER WITH 3-CHANNEL SAMPLING 13-BIT SIN/D INTERPOLATION

For the purpose of input signal stabilization the conditioned signals are fed into level controllers featuring current source outputs of up to 50 mA (master channel). These ACOx source pins either power the LEDs of an optical encoder or the magneto resistor bridges of a magnetic encoder. If the control thresholds are reached this event can be released for alarm messaging using the BiSS Interface or the NERR output. Both major chip functions and sensor errors are also monitored and can be enabled for alarm indication. In this manner typical sensor errors, such as signal loss due to wire breakage, short circuiting, dirt or aging, for example, can be signaled by alarms.

The device has other digital encoder functions governing the correction of phase errors between the tracks, for example, or the zeroing or default setting of a specific position offset for data output. Using the BiSS master also integrated on the chip position data from multiturn sensors, provided by a second iC-MN, for example, can be read in and synchronized.

Key Specifications

Operating Modes

- 3-Channel S&H interpolation
- 2- and 3-track Vernier calculation
- Config. multiturn modes (e.g. gearbox 3x 1:16, from 4 to 24 bit data)

Compatible Sensors				
	Photodiode arrays, AMR sensors, GMR sensors			
	Signal Conditioning			
	Differential Input Signal Range	20 mVpp to 1 Vpp, 80 mVpp to 4 Vpp		
	Input Current Range	+/- 10 μA to +/- 300 μA		
	Input Resistance	typ. 1.6 k Ω to 4.6 k Ω (I mode)		
		typ. 20 k Ω or high impedance (V mode		
	Permissible Input Frequency	to 200 kHz		
	Input Gain Range	1x to 50x and 4x to 200x		
	Gain Ratio Calibration Range	40 % to 250 % (sine vs. cosine)		
	Gain Calibration Step	0.09 %		
	Offset Calibration Range	to +/- 200, 400, 1200, 2400 %*		
	Offset Calibration Step	0.2 % , 0.4 %, 1.2 %, 3.2 %*		
		*) based on calibration ref.		
	Calibration Reference	0.25 V, 0.5 V, VDC, 5 % V(ACOM)		
	Phase Calibration Range	+/- 10.4 degree (sine vs. cosine)		
	Phase Calibration Step	0.02 degree		

Sine-to-Digital Conversion		
Conversion Time	250 to 500 ns per bit	
Conversion Time @ 24 bit Nonius	typ. 5 μs with cyclic readouts (15 μs for initialisation)	
Acceptable Nonius Scale Signal	2 ⁴ to 2 ¹² master signal periods per turn (ie. 16 to 4096)	
Angle Resolution	1 to 13 bits per signal period 6 to 13 bits per signal period for Nonius calc.	
Angle Accuracy	typ. 0.18° per signal period (calibrated)	

Data I/O Interface		
Interface Performance	10 Mbit/s for BiSS,	
	100 kHz / 2 MHz clock rate for SSI	
Differential RS422 Output	to +/- 50 mA push-pull, >2.5 V at RL 100 Ω	
Differential RS422 Receiver	Rin 20 k Ω , -7 to +12 V tolerant	

	Analog Output		
	Output Amplitude		to 300 mVp (@ RL 100 Ω pin-to-pin)
	Output Short-Circuit Current		typ. 30 mA
	Output Cutoff Frequency (-3 dB)		> 500 kHz
1			
	Signal Level Controlle	r	
	Operating Modes		constant current, sine square, sum
	Operating Ranges		to 5, 10 mA and to 25, 50 mA for master channel
	Source Saturation Voltage		1 V max.
	Control Alarm Threshold	S	approx. 2 % and 100 % of range limit
1			
	Sub-System Power Switch		
	Permissible Load Curren	t	to 20 mA
	Drop Out Voltage		typ. 200 to 300 mV @ 20 mA
1			
	Uther Operational Dat	a	
	Supply Voltage	single 4 (no cur	.5 to 5.5 V, typ. 45 mA rent draw with reversed polarity)
	Op. Temperature Range	-40 °C to +95 °C (extended range on request)	
	Package	MQFP44 (13.2 mm x 13.2mm), QFN48 (7x7 mm), bare die	
	Device Configuration	via BiSS or I2C interface from serial EEPROM	
	Monitoring and Alarms	lack of short-ci error du signal li overloa	input signal (due to wire breakage, ircuit, loss of magnet, etc), calculation ue to excessive input level or phase, evel controller out of range, thermal d, power up configuration error
	Other Operational	bias an	d temperature sensor calibration

mode, device test mode, digital calib. mode

Pin Functions

Modes

Name	Function
VDD*	+4.5 to 5.5 V Supply Voltage
GND*	Ground
VDDA	Sub-System Positive Supply Output
GNDA	Sub-System Ground Output
VACO*	+4.5 to 5.5 V Signal Level Controller Supply
ACOx*	Signal Level Controller Output
PSINx, NSINx	Pos./Neg. Sine Signal Input
PCINx, NCINx	Pos./Neg. Cosine Signal Input
PSOUT*, NSOUT*	Analog Pos./Neg. Sine Output
PCOUT*, NCSOUT*	Analog Pos./Neg. Cosine Output
SLO*, NSLO*	BiSS Interface, Pos./Neg. Data Output
MA*, NMA*	BiSS Interface, Pos./Neg. Clock Input
SLI	BiSS Interface, Data Input
MAO	BiSS Interface, Clock Repeater Output
MTMA	BiSS Master Interface, Clock Output
MTSLI	BiSS Master Interface, Data Input
SDA	Serial E2PROM Interface, Data Line
SCL	Serial E2PROM Interface, Clock Line
DIR	Sense of Rotation Preselection
PRES	Position Preset Trigger Input
NERR*	Alarm Message Output / System Error
	Message Input
T0T3	Test and Calibration I/O Pins
x= m (master), n (n	onius), s (segment)
*) Immune against faulty output or supply connections	

